Application/Control No.	Applicant(s)/Patent Under Reexamination
10785351	KORNECKI ET AL.
Examiner	Art Unit
Wang, Chang-Yu	1649
	10785351 <b>Examiner</b>

SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES				
Search Notes	Date	Examiner		
Sequence search: SEQ ID NO:1, nucleotides 16-912 and 97-912 of SEQ ID NO:1 & SEQ ID NO:3 and aa 28-299 of SEQ ID NO:3. See search results in SCORE (12/13/07) & (6/26/09)	9/27/10	CYW		
EAST, STN: search strategy attached (updated).	9/27/10	CYW		
Inventor name search: EAST, STN, PALM (updated).	9/27/10	CYW		
PLUS search from STIC. See search results in eDAN (9/27/10).	9/27/10	CYW		

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

/C. Y. W./ Examiner.Art Unit 1649	

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